New U.S. Patent Application Docket No. 32860-000625/US

Patent Claims

- 1. An X-ray detector (1) for a CT device (13) having, comprising:

 ____a phosphor layer, adapted to -(3) for generateing electromagnetic radiation as a function of anthe occurrence of X-radiation; and having ____a photodetector layer (9) for, adapted to -detecting the electromagnetic radiation generated by the phosphor layer (3), wherein characterized in that the phosphor layer includes (3) consists of ceramic material; and in that the photodetector layer (9) is joined to the phosphor layer, (3) and includes consists of organic material.
- 2. The X-ray detector (1)-as claimed in claim 1, wherein characterized in that the ceramic material is at least one of -Gd₂O₂S and or -CdWO₄.
- 3. The X-ray detector—(1) as claimed in <u>claim 1</u>, one of the preceding claims, characterized in that wherein the organic material is a mixture of p-type polyparaphenylene-vinylene (PPV) and n-type fullerene-phenyl-C61-butoxy-methoxine (fullerene-PCBM).
- 4. The X-ray detector (1)—as claimed in one of the preceding claims, characterized in that claim 1, further comprising:

 an intermediate layer, (7) is arranged between the phosphor layer (3) and the photodetector layer (9)—and is—joined to the photodetector layer (9).
- 5. The X-ray detector (1)-as claimed in claim 4, wherein characterized in that the intermediate layer includes (7) consists of a polymer.
- 6. The X-ray detector (1)-as claimed in claim 5, eharacterized in that wherein the polymer is polyethylene-dioxy-thiophene-polystyrene sulfonate (PEDOT-PSS).
- 7. The X-ray detector (1)—as claimed in <u>claim 1 one</u>, <u>wherein a —of the preceding claims</u>, <u>oharacterized in that the bottom electrode is provided and —(5) eonsists of includes an oxide.</u>
- 8. The X-ray detector (1)-as claimed in claim 7, wherein characterized in that the oxide is indium-doped tin oxide (ITO).

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- 9. The X-ray detector—(1) as claimed in one of the preceding elaimsclaim 1, eharacterized in that further comprising a top electrode—(11), which is joined to the photodetector layer—(9), is provided.
- 10. The X-ray detector (1)-as claimed in claim 9, wherein eharacterized in that the top electrode includes at least one of (11) consists of a metal andor a metal alloy.
- 11. The X-ray detector-(1) as claimed in claim 9, wherein characterized in that the top electrode (11) consists of includes a conductive polymer.
- 12. A CT device (13), characterized in that it comprisinges an the X-ray detector (1) as claimed in claim 1 one of the preceding claims.
- 13. A process for producing an X-ray detector (1)-for a CT device (13) having including a phosphor layer—(3), useable to for generateing electromagnetic radiation as a function of the occurrence of X-radiation, and having an organic photodetector layer, useable—(9) forto detecting the generated electromagnetic radiation—generated by the phosphor layer (3), characterized by the process steps of comprising:
- producing a-the phosphor layer (3) from a ceramic material; and
 applying a-the photodetector layer, (9) made from an organic material, to
 the phosphor layer (3) by means of via at least one of a spinning
 processing, printing processing, or beam/jet processing and or by sticking
 it-the photodetector layer on the phosphor layer as a film.
- 14. The process as claimed in claim 13, characterized by the further process step of further comprising:
- polishing the a surface of the phosphor layer (3) before applying the photodetector layer (9).
- 15. The process as claimed in one of the preceding claims 13 or 14, characterized by the further process step of comprising:
- applying an intermediate layer (7) to the phosphor layer (3) by means of via at least one of spinning processing, printing processing, beam/jet processing and sticking the photodetector layer on the phosphor layer as a

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filma spinning, printing or beam/jet process or by sticking it on as a film, before applying the photodetector layer-(9).

- The X-ray detector as claimed in claim 2, wherein the organic material is a mixture of p-type polyparaphenylcne-vinylene (PPV) and n-type fullerene-phenyl-C61-butoxy-methoxine (fullerene-PCBM).
- The X-ray detector as claimed in claim 2, further comprising: 17. an intermediate layer, arranged between the phosphor layer and the photodetector layer and joined to the phosphor layer and to the photodetector layer.
- The X-ray detector as claimed in claim 3, further comprising: 18. an intermediate layer, arranged between the phosphor layer and the photodetector layer and joined to the phosphor layer and to the photodetector layer.
- The X-ray detector as claimed in claim 16, further comprising: an intermediate layer, arranged between the phosphor layer and the photodetector layer and joined to the phosphor layer and to the photodetector layer.
- 20. The X-ray detector as claimed in claim 17, wherein the intermediate layer includes a polymer.
- The X-ray detector as claimed in claim 20, wherein the polymer is polyethylene-dioxy-thiophene-polystyrene sulfonate (PEDOT-PSS).
- The X-ray detector as claimed in claim 18, wherein the intermediate layer 22. includes a polymer.
- The X-ray detector as claimed in claim 22, wherein the polymer is polyethylene-dioxy-thiophene-polystyrene sulfonate (PEDOT-PSS).
- 24.__ The X-ray detector as claimed in claim 19, wherein the intermediate layer includes a polymer.
- 25. The X-ray detector as claimed in claim 24, wherein the polymer is polyethylene-dioxy-thiophene-polystyrene sulfonate (PEDOT-PSS).

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- The X-ray detector as claimed in claim 7, further comprising a top electrode, joined to the photodetector layer.
- 27. The process as claimed in claim 14, further comprising:
 - applying an intermediate layer to the phosphor layer via at least one of spinning processing, printing processing, beam/jet processing and sticking the photodetector layer on the phosphor layer as a film, before applying the photodetector layer.
- An X-ray detector, comprising:
- means for generating electromagnetic radiation as a function of an occurrence of X-radiation, including a phosphor layer; and
- means for detecting electromagnetic radiation generated by the phosphor layer, including a photodetector layer, wherein the phosphor layer includes ceramic material and the photodetector layer is joined to the phosphor layer, and includes organic material.
- The X-ray detector as claimed in claim 28, wherein the ceramic material is at least one of Gd2O2S and CdWO4.
- 30. The X-ray detector as claimed in claim 28, wherein the organic material is a mixture of p-type polyparaphenylene-vinylene (PPV) and n-type fullerenephenyl-C61-butoxy-methoxine (fullerene-PCBM).
- The X-ray detector as claimed in claim 28, further comprising: an intermediate layer, arranged between the phosphor layer and the photodetector layer and joined to the phosphor layer and to the photodetector layer.
- The X-ray detector as claimed in claim 31, wherein the intermediate layer 32. includes a polymer.
- The X-ray detector as claimed in claim 32, wherein the polymer is 33. polyethylene-dioxy-thiophene-polystyrene sulfonate (PEDOT-PSS).
- 34. A CT device comprising the X-ray detector as claimed in claim 28.